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Application/Control No.	Applicant(s)/Patent under Reexamination
09/919,365	ZHANG ET AL.
Examiner	Art Unit
John B. Walsh	2151

			
	SEAR	CHED	
Class	Subclass	Date	Examiner
709	226,238 239,240	2/16/2007	JW
709	242,244	2/16/2007	JW
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
inventor name search	2/1/2007	JW
text search in EAST-see attached search history	2/16/2007	JW
NPL-IEEExplore search	2/16/2007	WL
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